

#### MOSFET

#### 650V CoolMOS™ CM8 Power Transistor

The CoolMOS™ 8th generation platform is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. The 650V CoolMOS™ CM8 series is the successor to the 650V CoolMOS™ 7 Family and is enhancing Infineon's WBG offering. It combines the benefits of a fast switching SJ MOSFET with excellent ease of use, e.g low ringing tendency, implemented fast body diode (CFD) for all products with outstanding robustness against hard commutation and excellent ESD capability. Furthermore, extremely low switching and conduction losses of CM8, make switching applications even more efficient.

### **Features**

- Best in class 650V SJ MOSFET performance
- Suitable for hard and soft switching topologies thanks to an outstanding commutation ruggedness
- Integrated fast body diode and ESD protection
- .XT interconnection technology for best in class thermal performance

#### **Benefits**

- Ease of use and fast design-in through low ringing tendency and usage across PFC and PWM stages
- Simplified thermal management due to our advanced die attach technique
- Increased power density solutions enabled by using products with smaller footprint and higher manufacturing quality due state of the art ESD protection
- Suitable for a wide variety of applications and power ranges

### Potential applications

- Power supplies and converters
- PFC stages & LLC resonant converters
- High efficiency switching applications
- e.g. Datacenter, Al Server, Telecom Power Supply

#### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

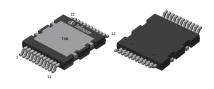
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.

Table 1 Key performance parameters

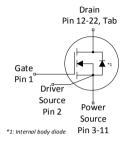
| . u = 1(0) p                         | unce pui | u    |  |
|--------------------------------------|----------|------|--|
| Parameter                            | Value    | Unit |  |
| V <sub>DS</sub> @ T <sub>j,max</sub> | 700      | V    |  |
| R <sub>DS(on),max</sub>              | 8        | mΩ   |  |
| $Q_{g,typ}$                          | 375      | nC   |  |
| I <sub>D,pulse</sub>                 | 1100     | А    |  |
| E <sub>oss</sub> @ 400V              | 42.0     | μЈ   |  |
| Body diode di <sub>F</sub> /dt       | 1300     | A/μs |  |
| ESD class (HBM)                      | 2        |      |  |

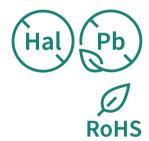
| Type / Ordering code | Package     | Marking  | Related links  |
|----------------------|-------------|----------|----------------|
| IPDQ65R008CM8        | PG-HDSOP-22 | 65R008C8 | see Appendix A |





O-DPAK





### **Public**

# 650V CoolMOS™ CM8 Power Transistor IPDQ65R008CM8



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# **1 Maximum ratings** at $T_j = 25$ °C, unless otherwise specified

Maximum ratings Table 2

| Davamatav                               | Compleal             |      | Values |            | 1155 | Note / Test condition   |  |
|---|----------------------|------|--------|------------|------|---|--|
| Parameter                               | Symbol               | Min. | Тур.   | Max.       | Unit |   |  |
| Continuous drain current <sup>1)</sup>  | I <sub>D</sub>       | -    | -      | 270<br>170 | А    | T <sub>c</sub> =25°C<br>T <sub>c</sub> =100°C                           |  |
| Pulsed drain current <sup>2)</sup>      | I <sub>D,pulse</sub> | -    | -      | 1100       | А    | T <sub>c</sub> =25°C  |  |
| Avalanche energy, single pulse          | E <sub>AS</sub>      | -    | -      | 647        | mJ   | L =7.4A+1/ =50\/: coo table 10  |  |
| Avalanche energy, repetitive            | E <sub>AR</sub>      | -    | -      | 3.24       | mJ   | I <sub>D</sub> =7.4A; V <sub>DD</sub> =50V; see table 10                |  |
| Avalanche current, single pulse         | I <sub>AS</sub>      | -    | -      | 7.4        | А    | -   |  |
| MOSFET dv/dt ruggedness                 | dv/dt                | -    | -      | 120        | V/ns | V <sub>DS</sub> =0400V  |  |
| Gate source voltage (static)            | $V_{\rm GS}$         | -20  | -      | 20         | V    | static;   |  |
| Gate source voltage (dynamic)           | $V_{\rm GS}$         | -30  | -      | 30         | V    | AC (f>1 Hz)   |  |
| Power dissipation                       | $P_{\rm tot}$        | -    | -      | 1249       | W    | T <sub>C</sub> =25°C  |  |
| Storage temperature                     | $T_{\rm stg}$        | -55  | -      | 150        | °C   |   |  |
| Operating junction temperature          | $T_{\rm j}$          | -55  | -      | 150        | °C   |   |  |
| Extended operating junction temperature | $T_{\rm j}$          | 150  | -      | 175        | °C   | ≤50 h in the application lifetime                                       |  |
| Mounting torque                         | -                    | -    | -      | -          | Ncm  | -   |  |
| Continuous diode forward current        | I <sub>S</sub>       | -    | -      | 270        | А    | T -250C   |  |
| Diode pulse current <sup>2)</sup>       | $I_{S,pulse}$        | -    | -      | 1100       | А    | <i>T</i> <sub>C</sub> =25°C   |  |
| Reverse diode dv/dt <sup>3)</sup>       | dv/dt                | -    | -      | 70         | V/ns | V <sub>DS</sub> =0400V, I <sub>SD</sub> ≤200A, T <sub>i</sub> =25°C see |  |
| Maximum diode commutation speed         | di <sub>F</sub> /dt  | -    | -      | 1300       | A/μs | table 8   |  |
| Insulation withstand voltage            | V <sub>ISO</sub>     | -    | -      | n.a.       | V    | V <sub>rms</sub> , T <sub>C</sub> =25°C, <i>t</i> =1min                 |  |

 $<sup>^{1)}</sup>$  Limited by  $T_{j,max}$ 

Pulse width  $t_p$  limited by  $T_{j,max}$ 

 $<sup>^{\</sup>rm 3)}$   $\,$  Identical low side and high side switch with identical  $\rm R_{G}$ 



## 2 Thermal characteristics

### Table 3 Thermal characteristics

| Parameter  | Symbol            | Values |      |      | 1154  | Note / Test condition   |
|--|-------------------|--------|------|------|-------|---|
| Parameter  | Syllibor          | Min.   | Тур. | Max. | Joint | Note / Test condition   |
| Thermal resistance, junction - case                    | $R_{\rm thJC}$    | -      | -    | 0.1  | K/W   | -   |
| Thermal resistance, junction - ambient                 | R <sub>thJA</sub> | -      | -    | 62   | K/W   | device on PCB, minimal footprint  |
| Thermal resistance, junction - ambient for SMD version | $R_{thJA}$        | -      | 45   | 55   | K/W   | Device on 40mm*40mm*1.5mm<br>epoxy PCB FR4 with 6cm² (one<br>layer, 70µm thickness) copper<br>area. Tap exposed to air. PCB is<br>vertical without air stream<br>cooling. |
| Soldering temperature, reflow soldering allowed        | $T_{sold}$        | -      | -    | 260  | °C    | reflow MSL1   |



### 3 Electrical characteristics

at  $T_i$ =25°C, unless otherwise specified

Table 4 Static characteristics

| Parameter                        | Symbol             | Values |                |       | Linit | Note / Test condition   |  |
|----------------------------------|--------------------|--------|----------------|-------|-------|---|--|
| Parameter                        | Symbol             | Min.   | Тур.           | Max.  |       | Note / Test condition   |  |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$      | 650    | -              | -     | V     | $V_{\rm GS}$ =0V, $I_{\rm D}$ =1mA  |  |
| Gate threshold voltage           | $V_{\rm (GS)th}$   | 3.7    | 4.2            | 4.7   | V     | $V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 3.24 \rm mA$  |  |
| Zero gate voltage drain current  | $I_{\mathrm{DSS}}$ | -      | -<br>976       | 4     | μΑ    | $V_{\rm DS}$ =650V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =25°C<br>$V_{\rm DS}$ =650V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =150°C     |  |
| Gate-source leakage current      | I <sub>GSS</sub>   | -      | -              | 0.1   | μΑ    | $V_{\rm GS}$ =20V, $V_{\rm DS}$ =0V   |  |
| Drain-source on-state resistance | $R_{\rm DS(on)}$   | -      | 0.007<br>0.015 | 0.008 | Ω     | $V_{\rm GS}$ =10V, $I_{\rm D}$ =125.0A, $T_{\rm j}$ =25°C<br>$V_{\rm GS}$ =10V, $I_{\rm D}$ =125.0A, $T_{\rm j}$ =150°C |  |
| Gate resistance                  | $R_{G}$            | -      | 1              | -     | Ω     | <i>f</i> =1MHz  |  |

### Table 5 Dynamic characteristics

| Parameter  | Cymphal            | Values |       |      | l lmit | Note / Test condition  |  |
|--|--------------------|--------|-------|------|--------|--|--|
|  | Symbol             | Min.   | Тур.  | Max. | Onit   | Note / Test condition  |  |
| Input capacitance  | C <sub>iss</sub>   | -      | 18004 | -    | pF     | 1/ -0/ 1/ -400// <del>[</del> 250]/ -                        |  |
| Output capacitance   | Coss               | -      | 193   | -    | pF     | $V_{\rm GS}$ =0V, $V_{\rm DS}$ =400V, $f$ =250kHz            |  |
| Effective output capacitance, energy related <sup>4)</sup> | $C_{\rm o(er)}$    | -      | 526   | -    | pF     | V <sub>GS</sub> =0V, V <sub>DS</sub> =0400V                  |  |
| Effective output capacitance, time related <sup>5)</sup>   | C <sub>o(tr)</sub> | -      | 5840  | -    | pF     | $I_{\rm D}$ =constant, $V_{\rm GS}$ =0V, $V_{\rm DS}$ =0400V |  |
| Turn-on delay time   | $t_{ m d(on)}$     | -      | 49    | -    | ns     |  |  |
| Rise time  | t <sub>r</sub>     | -      | 16.7  | -    | ns     | $V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =64.7A,   |  |
| Turn-off delay time  | $t_{ m d(off)}$    | -      | 218.6 | -    | ns     | $R_{\rm G}$ =1.8 $\Omega$ ; see table 9                      |  |
| Fall time  | t <sub>f</sub>     | -      | 4.5   | -    | ns     |  |  |

<sup>4)</sup>  $C_{
m o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{
m oss}$  while  $V_{
m DS}$  is rising from 0 to 400V

<sup>5)</sup>  $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V



### Table 6 Gate charge characteristics

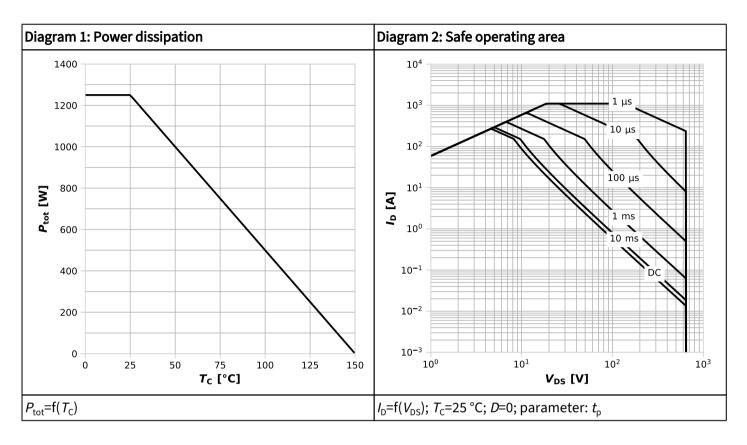
| Parameter             | Symbol            | Values |      |      | Linit | Note / Test condition  |  |
|-----------------------|-------------------|--------|------|------|-------|--|--|
| raiailletei           | Syllibol          | Min.   | Тур. | Max. | Oilit | Note / Test condition  |  |
| Gate to source charge | $Q_{\rm gs}$      | -      | 104  | -    | nC    | $V_{\rm DD}$ =400V, $I_{\rm D}$ =64.7A, $V_{\rm GS}$ =0 to 10V |  |
| Gate to drain charge  | $Q_{\mathrm{gd}}$ | -      | 116  | -    | nC    |  |  |
| Gate charge total     | $Q_{\mathrm{g}}$  | -      | 375  | -    | nC    |  |  |
| Gate plateau voltage  | $V_{ m plateau}$  | -      | 5.8  | -    | V     |  |  |

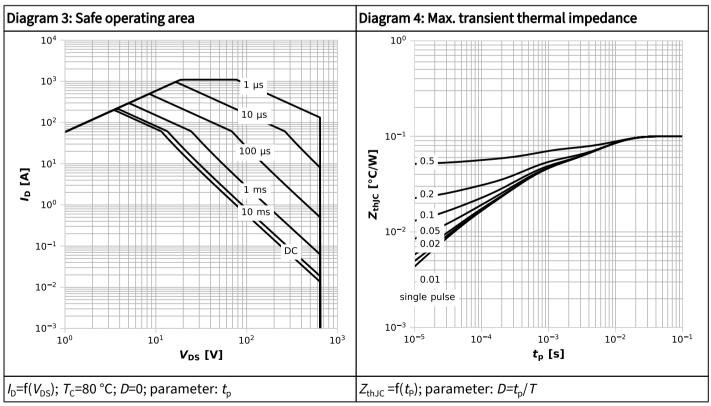
### Table 7 Reverse diode characteristics

| Parameter                     | Symbol           | Values |      |      | Linit | Note / Test condition  |
|-------------------------------|------------------|--------|------|------|-------|--|
|                               | Symbol           | Min.   | Тур. | Max. | Unit  | Note / Test condition  |
| Diode forward voltage         | $V_{\rm SD}$     | -      | 0.9  | -    | V     | V <sub>GS</sub> =0V, I <sub>F</sub> =64.7A, T <sub>j</sub> =25°C                       |
| Reverse recovery time         | t <sub>rr</sub>  | -      | 280  | 350  | ns    |  |
| Reverse recovery charge       | $Q_{\rm rr}$     | -      | 3.3  | 4.95 | 111(  | $V_{\rm R}$ =400V, $I_{\rm F}$ =64.7A, d $i_{\rm F}$ /d $t$ =100A/ $\mu$ s see table 8 |
| Peak reverse recovery current | I <sub>rrm</sub> | -      | 18.0 | -    | А     |  |

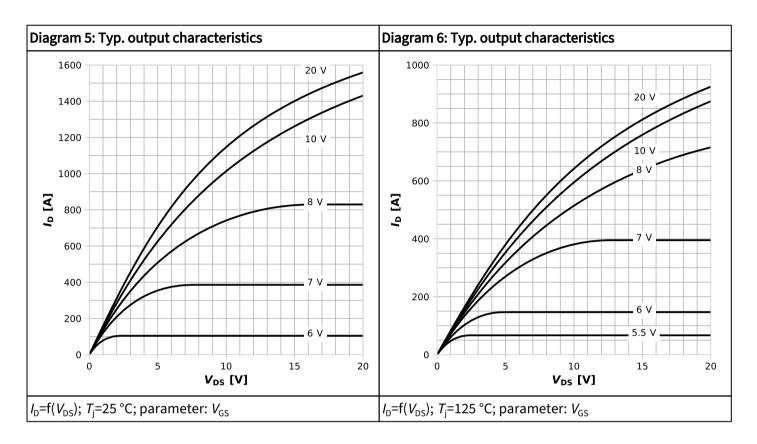


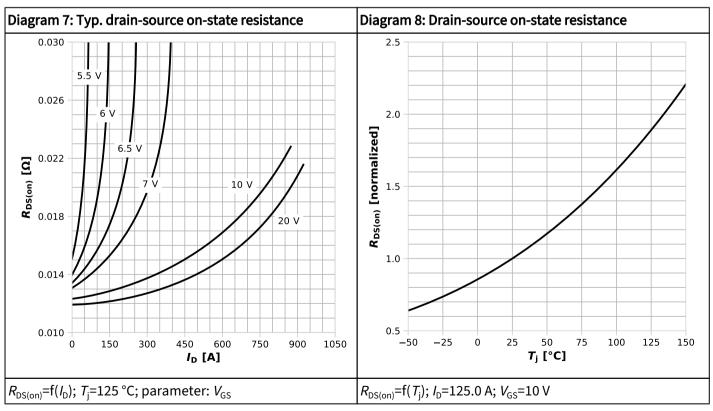
## 4 Electrical characteristics diagrams



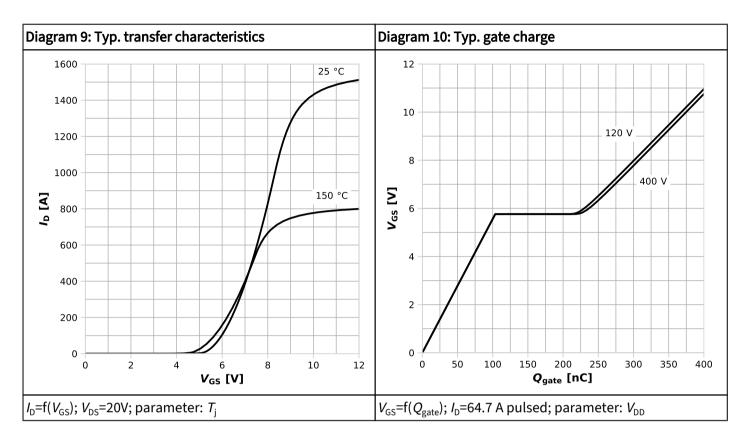


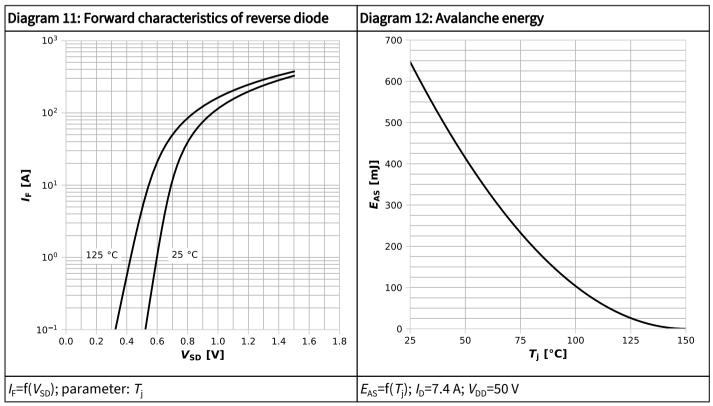




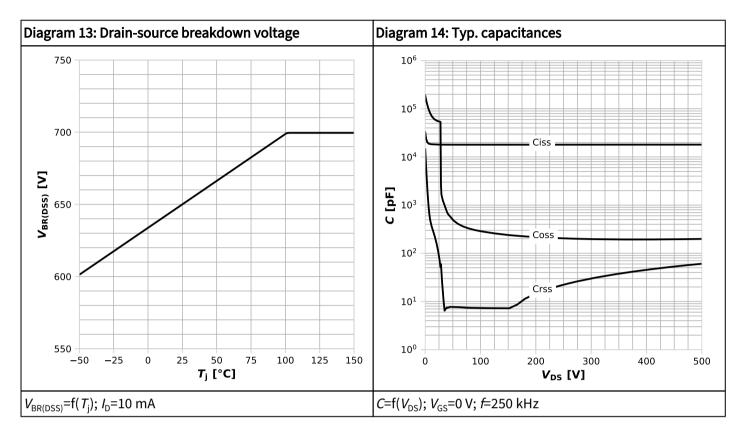


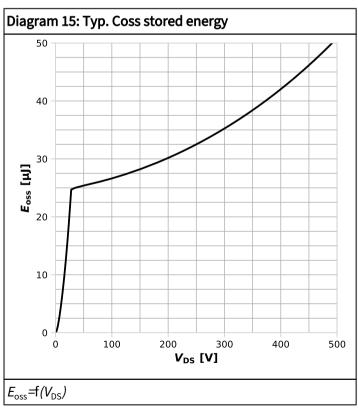














### 5 Test circuits

Table 8 Diode characteristics

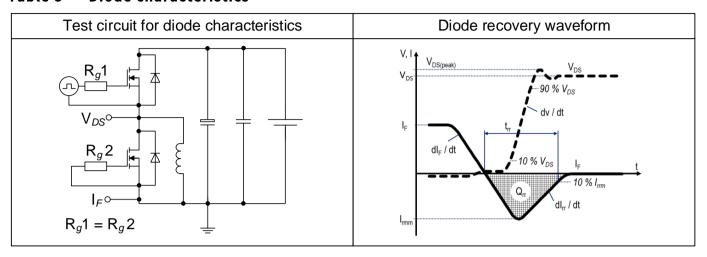


Table 9 Switching times (ss)

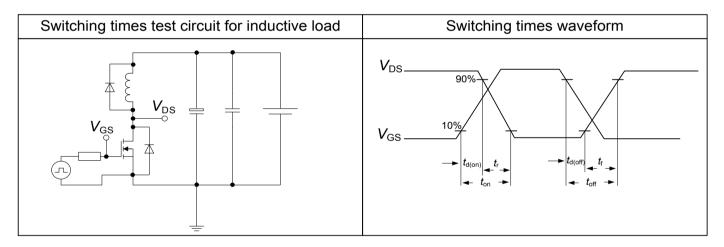
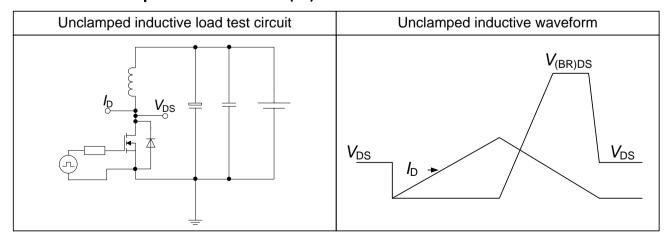


Table 10 Unclamped inductive load (ss)





## 6 Package outlines

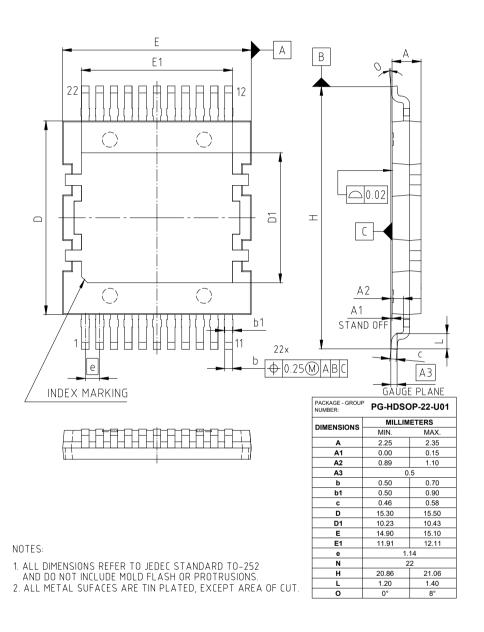


Figure 1 Outline PG-HDSOP-22, dimensions in mm



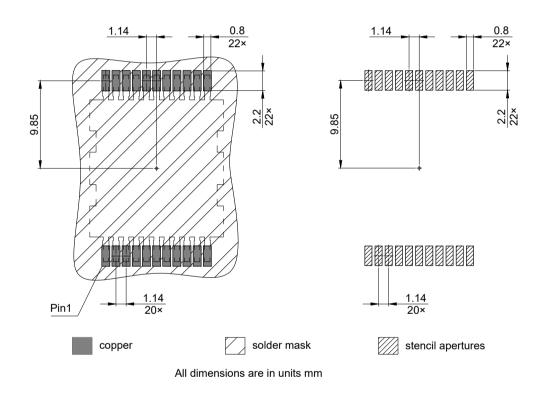
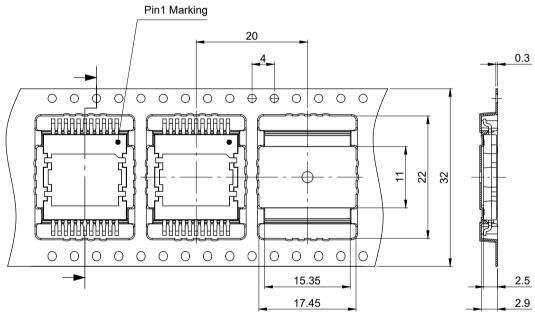


Figure 2 Footprint drawing PG-HDSOP-22, dimensions in mm





All dimensions are in units mm
The drawing is in compliance with ISO 128-30, Projection Method 1 [-□□□]

Figure 3 Packaging variant PG-HDSOP-22, dimensions in mm



## 7 Appendix A

### Table 11 Related links

- IFX CoolMOS CM8 Webpage
- IFX CoolMOS CM8 application note
- IFX CoolMOS CM8 simulation model
- IFX Design tools



### **Revision history**

IPDO65R008CM8

#### Revision 2024-12-19, Rev. 2.0

Previous revisions

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|--|
| 2.0      | 2024-12-19 | Release of final version                     |

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